

Search Notes



Application/Control No.

10/661,579

Examiner

Diem Tran

Applicant(s)/Patent under
Reexamination

NAKAGAWA ET AL.

Art Unit

3748

SEARCHED

Class	Subclass	Date	Examiner
60	284	10/24/05	DT
↓	285	↓	↓
	297		
	299		
↓	300	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR